## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CHEN, YUNG CHENG Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,735,078 B2	05-2004	Tsai, Chung Yen	361/695
*	В	US-6,668,565 B1	12-2003	Johnson et al.	62/89
*	С	US-6,439,992 B1	08-2002	Demeter, James Lee	454/184
*	D	US-6,301,110 B1	10-2001	Kodaira, Yuichi	361/697
*	Е	US-5,782,687 A	07-1998	Sniegocki, James	454/184
*	F	US-4,942,805 A	07-1990	Hellwig et al.	454/184
*	G	US-6,735,884 B2	05-2004	Fratello et al.	34/487
*	Н	US-6,600,649 B1	07-2003	Tsai et al.	361/697
*	1	US-6,679,686 B2	01-2004	Wang, Cheng-Chung	417/423.1
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.